



PATENT APPLICATION No.: 10/553,470
ATTORNEY DOCKET: 60291.000041

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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application Number : 10/553,470 Confirmation No.: 8935
Applicant : Ralf LERNER
Filed : May 19, 2006
Title : MONITORING THE REDUCTION IN THICKNESS AS
MATERIAL IS REMOVED FROM A WAFER COMPOSITE AND
TEST STRUCTURE FOR MONITORING REMOVAL OF
MATERIAL
TC/Art Unit : 2812
Examiner: : Unassigned

Docket No. : 60291.000041
Customer No. : 21967

MAIL STOP AMENDMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Sir:

In accordance with 37 C.F.R. §§ 1.97 and 1.98, and in compliance with the duty of disclosure set forth in 37 C.F.R. § 1.56, applicants submit attached Form PTO-SB/08B (modified) for consideration and request the references cited therein be made of record by the U.S. Patent and Trademark Office in the above-captioned application.

Applicants respectfully point out that the submission of the listed references in this Information Disclosure Statement is not an admission that they are prior art or that they are material to patentability of any claims of the application. Also, the submission of this Information Disclosure Statement is not an indication that a search has been made by Applicants.

For the convenience of the Examiner in considering the cited references, a copy of each of the cited references is enclosed with this communication. In considering the cited references, it may be noted by the Examiner that certain of the references may contain markings, underlinings, and/or other notations. These markings, underlinings, and/or other notations are not to be construed as drawing the Examiner's attention either to selected parts or away from other

parts of the cited references. Any such markings were either present on the copies of the cited references obtained by the associated individuals, or were made thereon during the study of the references by the associated individuals.

As this application was filed after June 30, 2003, copies of U.S. patents and/or U.S. patent application publications for national stage applications under 35 U.S.C. 371 cited on the attached Form PTO-SB/08B (modified), are not being provided as specified in 1276 *O.G.* 55 (5 August 2003).

Consideration of the foregoing plus the prompt return of a copy of the enclosed Form SB/08B with the Examiner's initials in the left column in accordance with MPEP 609 are respectfully requested.

In accordance with 37 C.F.R. § 1.97(b), this Information Disclosure Statement is believed to be submitted prior to issuance of a first Office Action. Therefore, it is respectfully submitted that no fee is required for consideration of this information. However, in the event any fee is deemed necessary, the Commissioner is authorized to charge the undersigned's Deposit Account No. 50-0206.

Respectfully submitted,

HUNTON & WILLIAMS LLP

Dated: 11/16/06

By: 
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Substitute for form 1449A/PTO

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(use as many sheets as necessary)

Application Number	10/553,470
Filing Date	May 19, 2006
First Named Inventor	Ralf LERNER
Art Unit	2812
Examiner Name	Unassigned
Attorney Docket Number	60291.000041

Sheet **1 of 3**

U.S. PATENT DOCUMENTS

*Examiner Initials	Cite No.	DOCUMENT NUMBER Number - Kind Code (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
	1.	US- 5,972,787	10-26-1999	Boggs, et al.	
	2.	US- 6,156,621	12-05-2000	Nance, et al.	
	3.	US- 6,242,320	06-05-2001	So	
	4.	US- 6,514,858	02-04-2003	Hause, et al.	
	5.	US- 6,515,826	02-04-2003	Hsiao, et al.	
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EXAMINER SIGNATURE	DATE CONSIDERED
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Substitute for form 1449/PTO

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(use as many sheets as necessary)

Application Number

10/553,470

Filing Date

May 19, 2006

First Named Inventor

Ralf LERNER

Art Unit

2812

Examiner Name**Unassigned****Sheet**

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Attorney Docket Number

60291.000041

FOREIGN PATENT DOCUMENTS

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EXAMINER SIGNATURE

DATE CONSIDERED

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		Filing Date	May 19, 2006
		First Named Inventor	Ralf LERNER
		Art Unit	2812
		Examiner Name	Unassigned
Sheet	3 of 3	Attorney Docket Number	60291.000041

OTHER DOCUMENTS - NON-PATENT LITERATURE DOCUMENTS

*Examiner Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	TRANSLATION	
			YES	NO
	9.	Hartmannsgruber, et al., "A Selective CMP Process for Stacked low- κ CVD Oxide Films", Microelectronic Engineering, Vol. 50, pg. 53-58, 2000.	<input type="checkbox"/>	<input type="checkbox"/>
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